Test Equipment Solutions Datasheet

Test Equipment Solutions Ltd specialise in the second user sale, rental and distribution of quality test & measurement (T&M) equipment. We stock all major equipment types such as spectrum analyzers, signal generators, oscilloscopes, power meters, logic analysers etc from all the major suppliers such as Agilent, Tektronix, Anritsu and Rohde & Schwarz.

We are focused at the professional end of the marketplace, primarily working with customers for whom high performance, quality and service are key, whilst realising the cost savings that second user equipment offers. As such, we fully test & refurbish equipment in our in-house, traceable Lab. Items are supplied with manuals, accessories and typically a full no-quibble 1 year warranty. Our staff have extensive backgrounds in T&M, totalling over 150 years of combined experience, which enables us to deliver industry-leading service and support. We endeavour to be customer focused in every way right down to the detail, such as offering free delivery on sales, presenting flexible technical + commercial solutions and supplying a loan unit during warranty repair, if available.

As well as the headline benefit of cost saving, second user offers shorter lead times, higher reliability and multivendor solutions. Rental, of course, is ideal for shorter term needs and offers fast delivery, flexibility, try-before-you-buy, zero capital expenditure, lower risk and off balance sheet accounting. Both second user and rental improve the key business measure of Return On Capital Employed.

We are based at Aldermaston in the UK from where we supply test equipment worldwide. Our facility incorporates Sales, Support, Admin, Logistics and our own in-house Lab.

All products supplied by Test Equipment Solutions include:

- No-quibble parts & labour warranty (we provide transport for UK mainland addresses).
- Free loan equipment during warranty repair, if available.
- Full electrical, mechanical and safety refurbishment in our 40GHz in-house Lab.
- Certificate of Conformance (calibration available on request).
- Manuals and accessories required for normal operation.
- Free insured delivery to your UK mainland address (sales).
- Support from our team of seasoned Test & Measurement engineers.
- ISO9001 quality assurance.

Test Equipment Solutions Ltd Unit 3 Zodiac House Calleva Park Aldermaston Berkshire RG7 8HN

T: 01183 800 800 F: 01183 800 804

Email: info@TestEquipmentHQ.com
Web: www.TestEquipmentHQ.com



2 Mbit/s Testing in the Palm of Your Hand

Sunlite E1

SUMRISE TELECOM

Fulfill your 2.048 Mbit/s transmission testing needs by using the world's smallest full-feature 2.048 Mbit/s transmission test set, the SunLite E1. Among its capabilities are:

- 2.048 Mbit/s transmit, receive and external clock
- Bit error rate testing (ITU-T G.821)
- ITU-T G.826, M.2100 analysis
- Level and frequency measurements
- +6 to -43 dB receiver input sensitivity
- Term, PMP (Monitor), High Impedance
- Drop and insert capability (N or Mx64k)
- Programmable NFAS Word
- CAS signaling
- Histogram analysis
- Propagation delay
- Store up to 10 test results and 10 configurations
- 75Ω and 120Ω models
- Powered by rechargeable NimH battery pack

Put this economical, yet powerful SunLite E1 in your shirt pocket. For more information and the name of your local Sunrise Telecom distributor, visit www.sunrisetelecom.com.



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info@sunrisetelecom.com

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The SunLite E1 gives you the choice of 75 Ω unbalanced or 120 Ω balanced connectors.

A bright backlit LCD display is ideal for often encountered low light working conditions.

Bright LED indicators provide immediate circuit status and history at a glance.

With a single keystroke you can configure the SunLite E1 to your circuit and call up the menu for the test you wish to perform.

The speaker and microphone allow you to monitor the channel or to talk-and-listen.

The test set operates continuously from the charger.



SPECIFICATIONS

Connectors/Ports

2.048 Mbit/s E1 interfaces: Tx, Rx, Ext Clock Standard: BNC (f), 75Ω unbalanced connectors Optional: BR2 (f) 120Ω balanced connectors; Bantam (f) 120Ω balanced connectors

Serial Port: RS-232/V.24, RJ11, 6-pins connector Charger: 1 mm, DC jack

Status/Alarm Indicators

13 super-bright LED indicators Current status and alarm history Signal: red, no signal; green, signal; flash red, history PCM-30 (bi-color), CRC-4 (bi-color), SYNC (bi-color) TX: solid green, transmitter activated; flash green in selfloop mode; off, transmitter deactivated RUN: green, measurement running; off, measurement

stop RAI: red, MFAS RAI or FAS RAI; flash red, history AIS: red, AIS; flash, history CODE: red, code error; flash, history ERROR: red, CRC-4, E-bit, FAS E; flash, history BIT: red, logical bit error; flash red, history Power/low batt: slow flash green, power on & battery fully charged; solid green, battery being charged;

E1 General

Bit Error test rates: 2.048 Mbit/s, N (contiguous) and M (non-contiguous) x 64 kbit/s (N & M=1 to 31) Drop and insert to internal test circuitry N or Mx64 kbit/s $\dot{\mu}/A\text{-law}$ decoded VF channel to built-in speaker Line Coding: HDB3 & AMI

Framing: Unframed, PCM-30, PCM-30C, PCM-31, PCM-31C Conforms to ITU-T G.704

Test Pattern Generator

red, low battery

General: 1111..., 0000..., 1010..., RICAR 3 PRBS: 2ⁿ-1, n= 9, 11, 15, 23. Conforms to ITU-T 0.151, 0.152, 0.153, and ANSI V.52, V.57

Programmable: 3 patterns, up to 16 bits long each Test pattern inversion

Transmitter

Clock source

Internal clock: 2.048 MHz ± 25 ppm Received: locked to received signal
External: locked to Reference clock input signal

Line coding: HDB3 & AMI Pulse shape: Conforms to ITU-T G.703. 75Ω/Unbal.:

±2.37 Vbp (±10%) Programmable Time slot 0: Programmable loop-up/loop-

down code, programmable NFAS word Set idle channel code and ABCD bits (IDLE/NOT IDLE state) Transmit signal can be turned ON/OFF or internally looped Error injection

BIT, CODE (single or rate of 1x10⁻⁷ to 1x10⁻⁷ BIT+CODE (single or rate of 1x10⁻⁷ to 1x10⁻³) CRC-4, FRAME, E-bit (single) 0-128 bit zero insertion in 8 bits steps

Frequency range: 2.048 Mbit/s ± 6000 bit/s for SLE1 Input Sensitivity

Terminate Hi-Z: 6 to -43 dB with Automatic Line Build

Monitor: -20 dB resistive loss with -6 dB cable loss Auto configuration for framing (PCM-30, PCM-30C, PCM-31, PCM-31C, Unframed), and test pattern Impedances

Terminate, Monitor: 75Ω unbalanced Hi-Z: >2000Ω

Return loss performance according to ITU-T G.703 Jitter tolerance according to ITU-T 6.823

External Clock Interface

Input Impedance: 75Ω Unbalanced Input Sensitivity: -20 dB resistive loss with -6 dB cable loss Line Coding: HDB3 & AMI

Measurements

E1 signal level: +0 to -43 dB resolution: 1 dB Frequency measurement (Hz & ppm): Selectable frequency resolution (1Hz, 0.1Hz and 0.01Hz) Current, Max, Min Clock slips count

Code errors: Error count and ratio

Frame errors: FAS and CRC-4 errors count and error ratios Count of LOS, Loss of Sync (SYLS), LOF, AIS, FAS RAI, and MFAS RAI seconds

Bit errors: ITU-T G.821 analysis with allocation, programmable HRX%

ITU-T G.826 measurements ITU-T M.2100 measurements (in conformance with M.2101)

E-bit errors: Error count and ratio Setup and test results printing

Test duration programmable
Print interval programmable: NOW, 5 min., 15 min., 1 hr.,
24 hrs., LAST, EVENT, OFF

Time stamped events printing Delay timer settable up to 99 hrs., 59 min. Audible alarm: Indicates an error or alarm, programmable ON/OFF

Alarm Generation: AIS, FAS RAI, MFAS RAI

Other Measurments

Save 10 test results, available to screen view or print with user defined label

Histograms: G.821 basic measurements, up to 60 days of histograms, 1 day resolution and the last 24 hrs. with 1 min. resolution. 2 HISTOGRAMS stored; CURRENT and SAVED

Propagation Delay measurements in UI & µs, 1 µs resolution Range: From 100 µs to 10 seconds View Received Data

Voice Frequency Capability

Talk/listen by using the built-in microphone/speaker Companding: A-law or μ -law (selectable) Monitor and CAS modes ABCD bits display for a selected timeslot

CAS signaling monitoring (IDLE/NOT IDLE state) Set ABCD bits to 1 or 0 of selected timeslot Set CAS state IDLE/NOT IDLE Set Idle Channel code

Frame Word Settings
Sa bits read, write with all 40 bits independently settable Selectable loopback/release commands Set Loop Up/Loop Down Sa4-8 bit code or transmit pattern

SLE1-01 Clock Offset Optionn

Transmitter

Frequency settable to 2.048 Mbit/s ± 24,400 ppm: 2.048 MHz

Accuracy: ± 2 ppm (after external calibration) Receiver

Frequency range: 2.048 Mbit/s ± 24,400 ppm Other measurements: Automatic stress automatically determines the receiving equipment's upper and lower frequency capture range

SLE1-02 VF Measurment Option VF Measurement: 50 Hz to 3950 Hz, 1 Hz Resolution; +3 dBm0 to -60 dBm0, 1 dB resolution

Send/Receive tone: 50 to 3950 Hz, res. 1 Hz; +3 to -60

dBm0, res. 1 dB Noise (S/N, psophometric, 3K) level measurement: +3 to -60 dBm0

Digital representation of sinusoidal signals in a selected timeslot: A-law and μ-law coding to ITU-T G.711 Coder offset and peak code measurement

General

Store and recall 10 instrument configurations 122x32 dots (4x20 characters, 6x8 dots size) graphic display screen with LCD backlight

Internal Battery: NimH

Battery operation time: 4 hrs, transmitter off
Unit charging time: 7 hrs

Charger: 5V @ 2A, 90 to 265 VAC, 50-60 Hz Printer/Communication port: RS-232, RJ11, 6-PIN asynch Language selection: English, Italian, French, German

Operating temperature: 0° C to 50° C Storage temperature: -20° C to +70° C Humidity: 5% to 90% non-condensing Dimensions: 175 mm (I) x 75 mm (w) x 35 mm (d) Weight: 0.4 kg (approx)



Sunrise Telecom 302 Enzo Drive San Jose, CA 95138 USA ph 1 408 363 8000 fax 1 408 363 8313



